## Application/Control No. O9/834,431 Applicant(s)/Patent Under Reexamination MABUCHI ET AL. Examiner Yogesh K Aggarwal U.S. PATENT DOCUMENTS \* Document Number Country Code-Number-Kind Code MM-YYYY Art Unit Page 1 of 1 Classification

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,130,420	10-2000	Tanaka et al.	250/208.1
	В	US-6,348,929	02-2002	Acharya et al.	345/660
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	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

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